

Notice of References Cited	Application/Control No. 09/943,690	Applicant(s)/Patent Under Reexamination WEIER ET AL.	
	Examiner Tae H Yoon	Art Unit 1714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,998,543	12-1999	Collins et al.	524/808
	B	US-6,130,288	10-2000	Inoue et al.	524/556
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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